

<b>Notice of References Cited</b>	Application/Control No. 09/827,476	Applicant(s)/Patent Under Reexamination IDE ET AL.	
	Examiner Thu V. Huynh	Art Unit 2178	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,622,171	09-2003	Gupta et al.	709/231
*	B	US-7,047,248	05-2006	Tycast, Robert Leonard	707/102
*	C	US-2004/0073947	04-2004	Gupta, Anoop	725/134
*	D	US-6,128,653	10-2000	del Val et al.	709/219
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.